

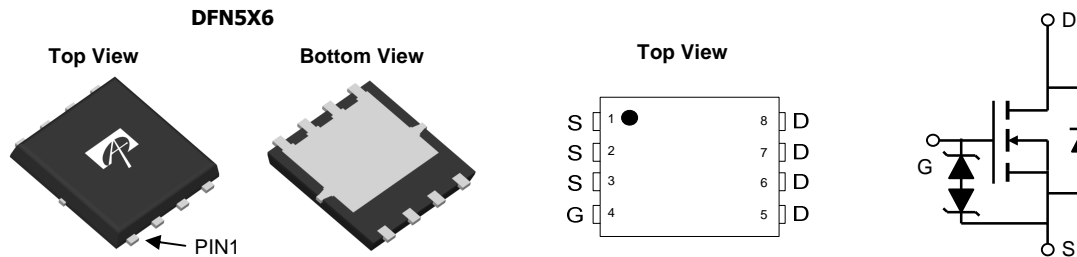
General Description

The AON6404 combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. This device is ideal for load switch and battery protection applications.

Product Summary

V_{DS} (V) = 30V
 I_D = 85A (V_{GS} = 10V)
 $R_{DS(ON)}$ < 2.2m Ω (V_{GS} = 10V)
 $R_{DS(ON)}$ < 3.8m Ω (V_{GS} = 4.5V)

ESD protected
 100% UIS Tested
 100% Rg Tested



Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter | Symbol | Maximum | Units |
|------------------------------------------|-------------------------|------------|------------------|
| Drain-Source Voltage | V_{DS} | 30 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | V |
| Continuous Drain Current ^{B,G} | $T_C=25^\circ\text{C}$ | 85 | A |
| | $T_C=100^\circ\text{C}$ | 67 | |
| Pulsed Drain Current | I_{DM} | 160 | |
| Continuous Drain Current ^A | $T_A=25^\circ\text{C}$ | 25 | |
| | $T_A=70^\circ\text{C}$ | 20 | |
| Avalanche Current | I_{AS} | 85 | |
| Single avalanche energy $L=0.1\text{mH}$ | E_{AS} | 361 | mJ |
| Power Dissipation ^B | $T_C=25^\circ\text{C}$ | 83 | W |
| | $T_C=100^\circ\text{C}$ | 33 | |
| Power Dissipation ^A | $T_A=25^\circ\text{C}$ | 2.1 | W |
| | $T_A=70^\circ\text{C}$ | 1.3 | |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | $^\circ\text{C}$ |

Thermal Characteristics

| Parameter | Symbol | Typ | Max | Units |
|------------------------------------------|-----------------|--------------|-----|--------------------|
| Maximum Junction-to-Ambient ^A | $R_{\theta JA}$ | 15 | 20 | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient ^A | | Steady-State | 45 | 60 |
| Maximum Junction-to-Case ^C | $R_{\theta JC}$ | 1.1 | 1.5 | $^\circ\text{C/W}$ |

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|-------------------------------------------------------------------------------------|-----|------|--------|------------------|
| STATIC PARAMETERS | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $I_D=250\mu\text{A}$, $V_{GS}=0\text{V}$ | 30 | 34 | | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=30\text{V}$, $V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$ | | | 1 5 | μA |
| I_{GSS} | Gate-Body leakage current | $V_{DS}=0\text{V}$, $V_{GS}=\pm 16\text{V}$ | | | 10 | μA |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}$, $I_D=250\mu\text{A}$ | 1.4 | 1.7 | 2 | V |
| $I_{D(ON)}$ | On state drain current | $V_{GS}=10\text{V}$, $V_{DS}=5\text{V}$ | 160 | | | A |
| $R_{DS(ON)}$ | Static Drain-Source On-Resistance | $V_{GS}=10\text{V}$, $I_D=20\text{A}$ $T_J=125^\circ\text{C}$ | | 1.8 | 2.2 | $\text{m}\Omega$ |
| | | $V_{GS}=4.5\text{V}$, $I_D=20\text{A}$ | | 2.5 | 3.1 | $\text{m}\Omega$ |
| g_{FS} | Forward Transconductance | $V_{DS}=5\text{V}$, $I_D=20\text{A}$ | | 75 | | S |
| V_{SD} | Diode Forward Voltage | $I_S=85\text{A}$, $V_{GS}=0\text{V}$ | | 0.87 | 1.3 | V |
| I_S | Maximum Body-Diode Continuous Current | | | | 85 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C_{iss} | Input Capacitance | $V_{GS}=0\text{V}$, $V_{DS}=15\text{V}$, $f=1\text{MHz}$ | | 7420 | 9000 | pF |
| C_{oss} | Output Capacitance | | | 1045 | | pF |
| C_{rss} | Reverse Transfer Capacitance | | | 720 | | pF |
| R_g | Gate resistance | $V_{GS}=0\text{V}$, $V_{DS}=0\text{V}$, $f=1\text{MHz}$ | | 1.2 | 1.8 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| $Q_g(10\text{V})$ | Total Gate Charge | $V_{GS}=10\text{V}$, $V_{DS}=15\text{V}$, $I_D=20\text{A}$ | | 118 | 155 | nC |
| $Q_g(4.5\text{V})$ | Total Gate Charge | | | 54 | | nC |
| Q_{gs} | Gate Source Charge | | | 29 | | nC |
| Q_{gd} | Gate Drain Charge | | | 22 | | nC |
| $t_{D(on)}$ | Turn-On Delay Time | $V_{GS}=10\text{V}$, $V_{DS}=15\text{V}$, $R_L=0.75\Omega$, $R_{GEN}=3\Omega$ | | 17 | | ns |
| t_r | Turn-On Rise Time | | | 18 | | ns |
| $t_{D(off)}$ | Turn-Off Delay Time | | | 67 | | ns |
| t_f | Turn-Off Fall Time | | | 25 | | ns |
| t_{rr} | Body Diode Reverse Recovery Time | $I_F=20\text{A}$, $dI/dt=100\text{A}/\mu\text{s}$ | | 60 | 80 | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | $I_F=20\text{A}$, $dI/dt=100\text{A}/\mu\text{s}$ | | 66 | | nC |

A: The value of $R_{\theta JA}$ is measured with the device in a still air environment with $T_A=25^\circ\text{C}$, with the device mounted on 1 in2 FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$

B: The power dissipation P_D is based on $T_{J(MAX)}=150^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsink is used.

C: Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}=150^\circ\text{C}$.

D: The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

E: The static characteristics in Figures 1 to 6 are obtained using $<300\mu\text{s}$ pulses, duty cycle 0.5% max.

F: These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}=150^\circ\text{C}$. The SOA curve provides a single pulse rating.

G: Maximum current is limited by the package.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

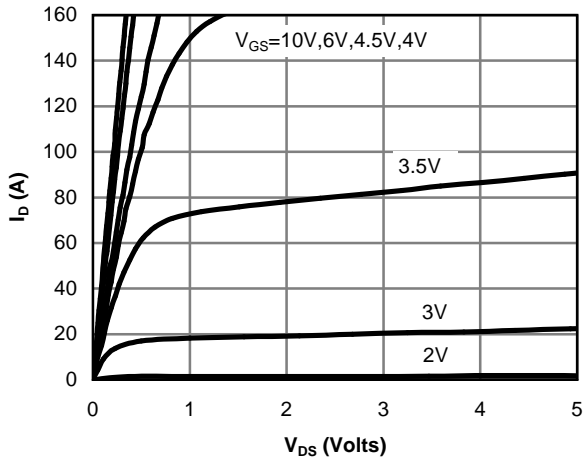


Fig 1: On-Region Characteristics

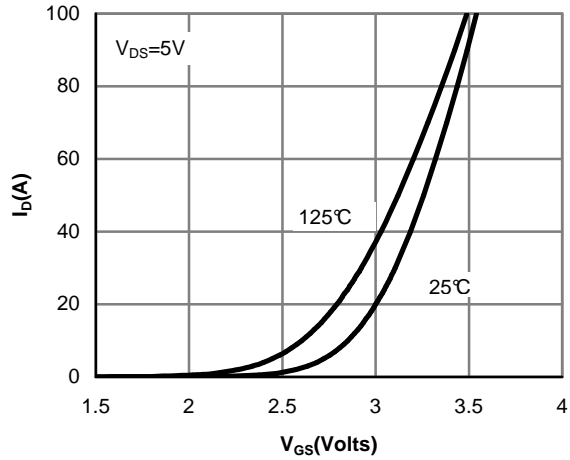


Figure 2: Transfer Characteristics

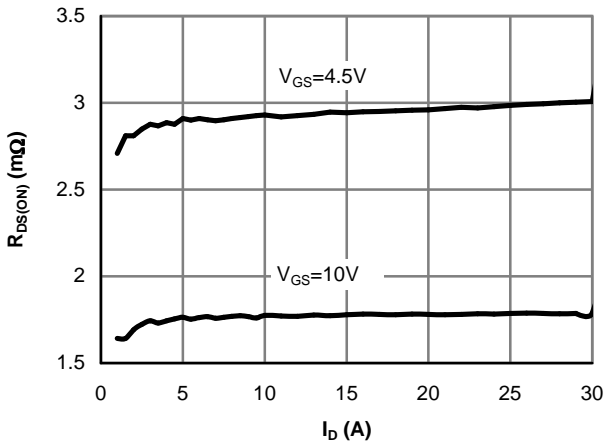


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

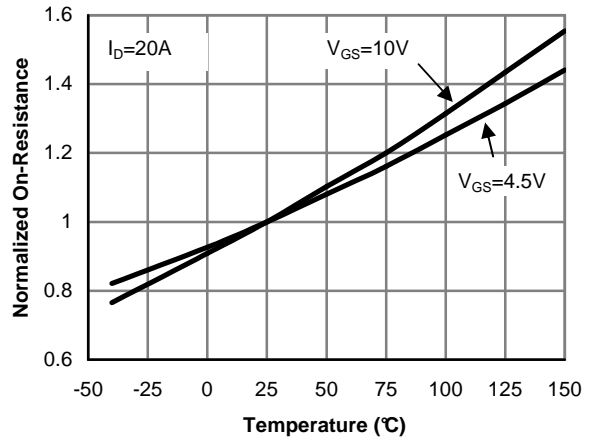


Figure 4: On-Resistance vs. Junction Temperature

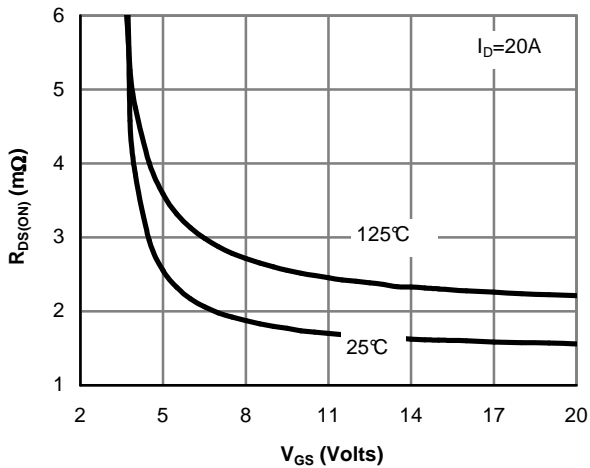


Figure 5: On-Resistance vs. Gate-Source Voltage

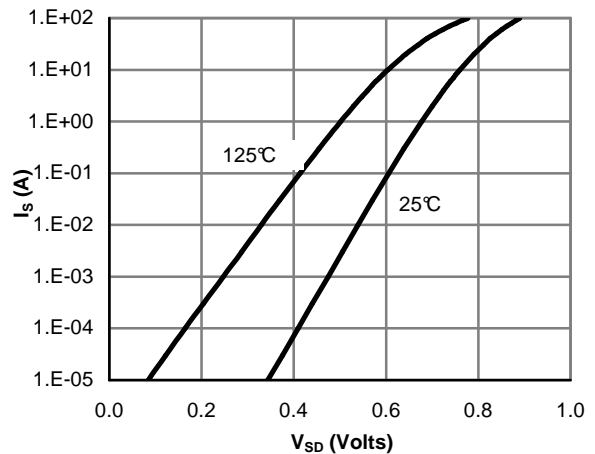


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

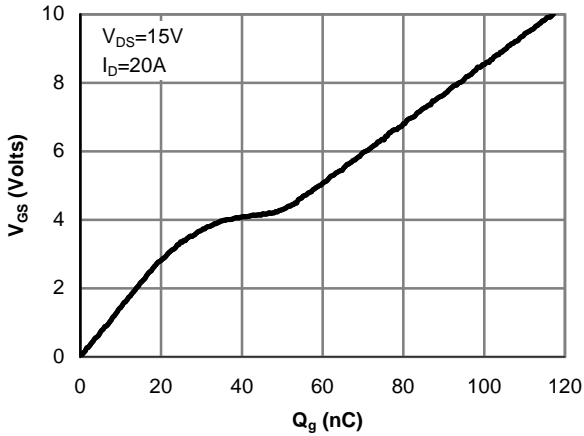


Figure 7: Gate-Charge Characteristics

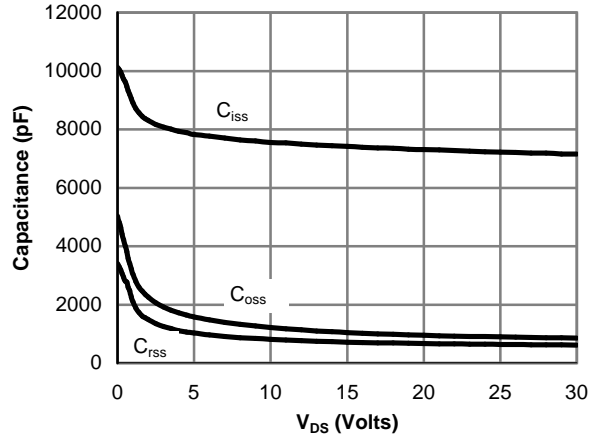


Figure 8: Capacitance Characteristics

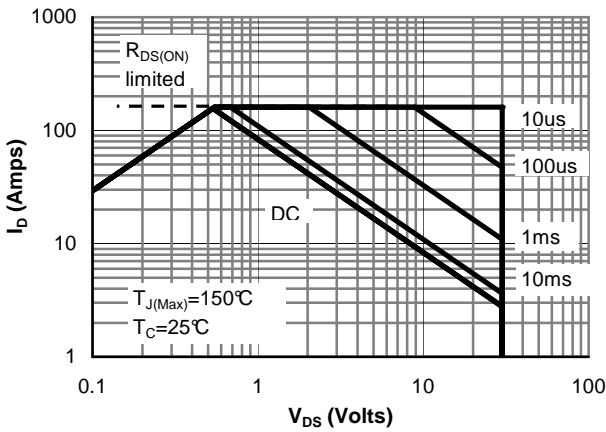


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

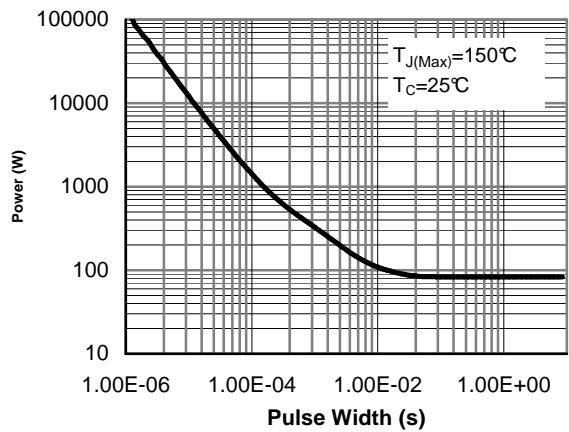


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

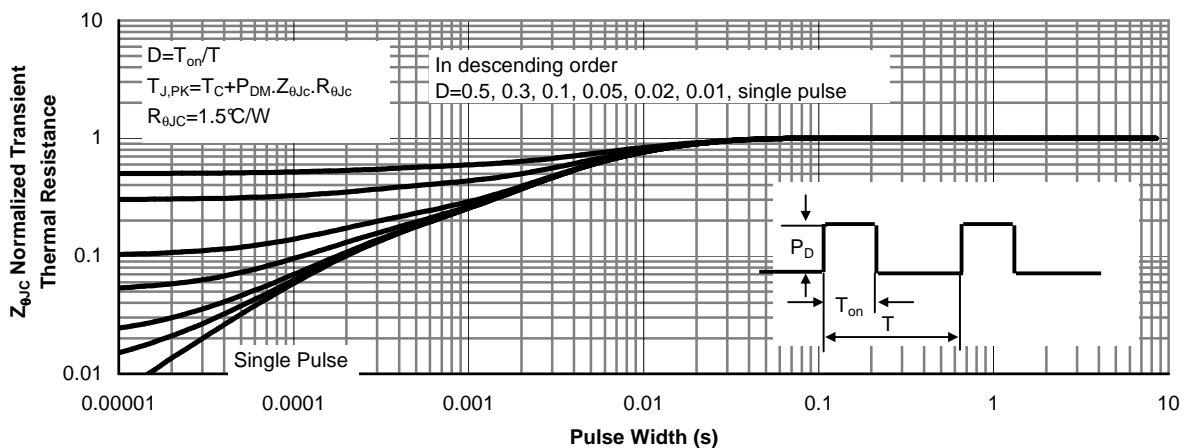


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

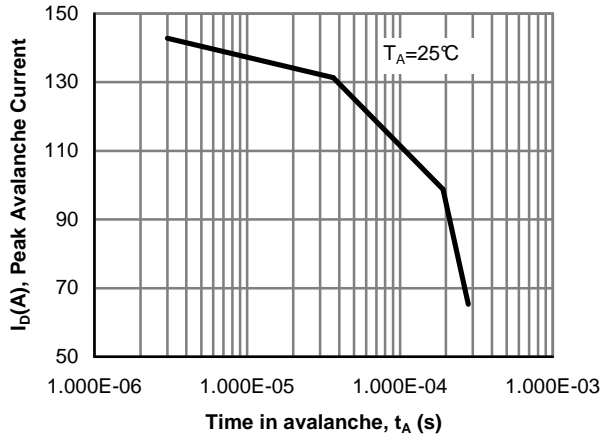


Figure 12: Single Pulse Avalanche capability

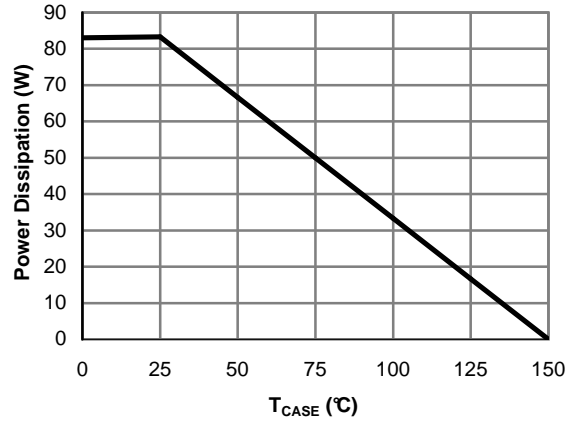


Figure 13: Power De-rating (Note B)

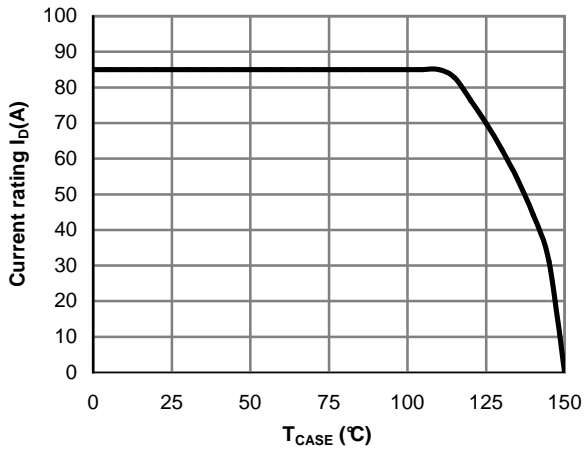


Figure 14: Current De-rating (Note B,G)

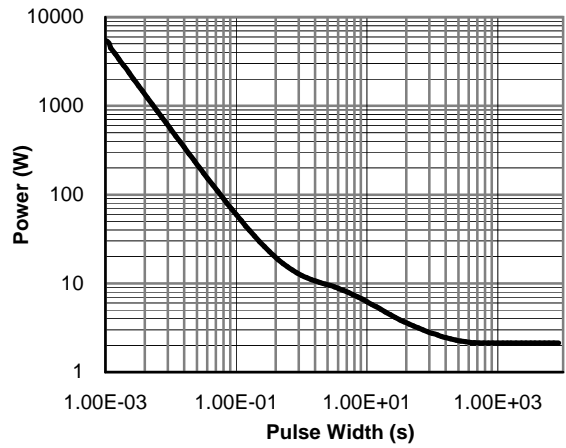


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note A)

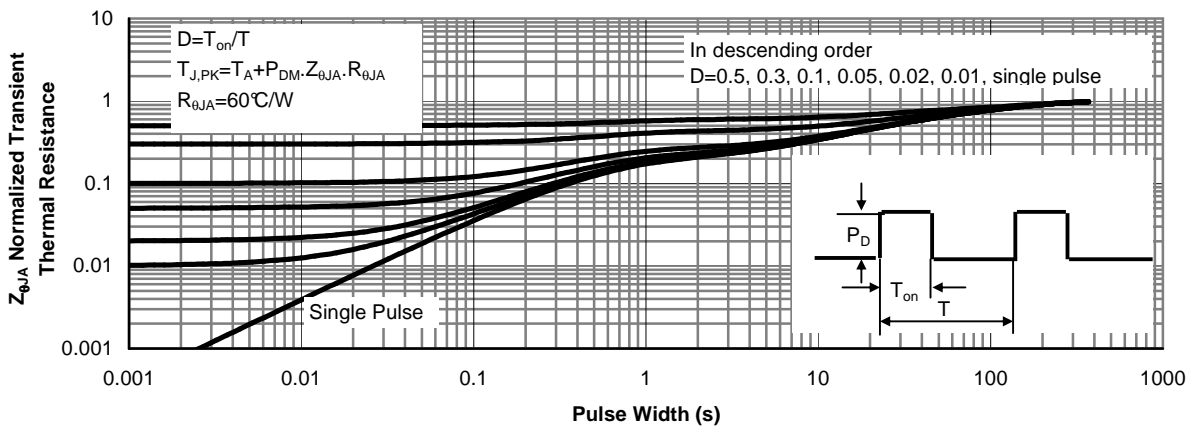
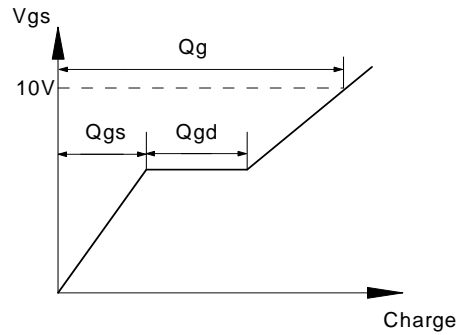
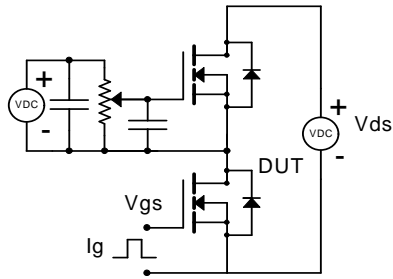
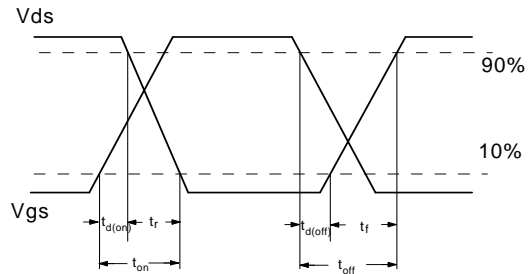
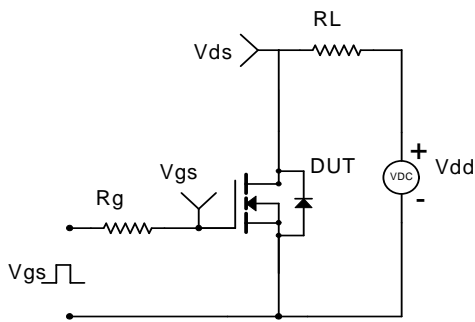


Figure 16: Normalized Maximum Transient Thermal Impedance (Note A)

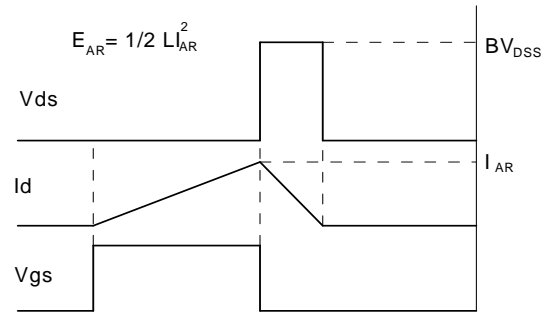
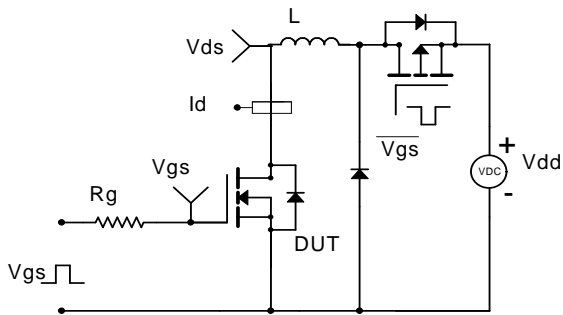
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

